

Notice of References Cited	Application/Control No. 10/729,937		Applicant(s)/Patent Under Reexamination SHIBAMIYA ET AL.	
	Examiner JASON K. LIN		Art Unit 2425	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,133,962	10-2000	Proehl et al.	725/44
*	B	US-5,808,608	09-1998	Young et al.	725/52
*	C	US-2002/0044144	04-2002	Inoue, Tatsu	345/204
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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